

<b>Notice of References Cited</b>	Application/Control No. 10/760,277	Applicant(s)/Patent Under Reexamination STERNE ET AL.	
	Examiner JEFFREY M. RUTKOWSKI	Art Unit 2619	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0009079 A1	01-2002	Jungck et al.	370/389
*	B	US-6,728,270 B1	04-2004	Meggers et al.	370/514
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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